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Substitute for form	1449A/P	10			_
		-	Application Number	10/046,858	
			Filing Date	1/13/2002	
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			Examiner Name	Garbowski, Leigh M.	
1	of	1	Attorney Docket Number	SPLX.P0124	
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Examiner* Initials	Cite No.1	For Office <sup>3</sup>	reign Patent Do Number <sup>4</sup>	cument Kind Code (if known) <sup>5</sup>	Date of Publication MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>8</sup>			
W	1.	JP	02-262354	4	10-25-1990	Kuribayashi, Molotaka					

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Examiner* Initials	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>6</sup>
W	2.	CONG J. et al., DUNE – A Multilayer Gridless Routing System, May 2001, IEEE Transactions on Computer-Aided Design of Integrated Circuits and Systems, vol 20, iss. 5, pp. 633-647.	

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<sup>\*</sup> EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. \*Applicant's unique citation designation number (optional). \*See Kinds Codes of USPTO Patent Documents at <a href="www.uspto.gov">www.uspto.gov</a> or MPEP 901.04. \*Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). \*For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. \*Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. \*Applicant is to place a check mark here if English language Translation is attached.

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## **ELECTRONIC INFORMATION DISCLOSURE STATEMENT**

Electronic Version v18 Stylesheet Version v18.0

> Title of Invention

Method and apparatus for placing circuit modules

Application Number:

10/046858

Confirmation Number:

6767

First Named Applicant:

Steven Teig

Attorney Docket Number: SPLX.P0124

Art Unit:

2825

Examiner:

LEIGH M. GARBOWSKI

Search string:

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or 6442745 or 6505331 or 6601227 or 20030014725 or 20040044979 ).pn.

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Note: Applicant is not required to submit a paper copy of cited US Patent Documents

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STATEMENT BY APPLICANT	Group Art Unit	2825	
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		U.S	S. PA	TENTS RELATED TO THE PRESEN	IT APPLICATION	S
Examiner Initials	Cite No. <sup>1</sup>			Name of Patentee or Applicant of Cited Document	Date of Publication MM-DD-YYYY	Relation to Present Application
No	1.	6,516,455	B1	Teig, et al.	02-04-03	CIP of parent application
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